

# **Current Transducer LDSR 0.3-TP/SP1**

 $I_{PRN} = 300 \text{ mA}$ 

For the electronic measurement of current: DC, AC, pulsed..., with galvanic separation between the primary and the secondary circuit.





#### **Features**

- Closed loop (compensated) current transducer
- Voltage output
- Single supply voltage
- PCB mounting.

#### **Special feature**

• Dedicated primary PCB.

#### **Advantages**

- · Very low offset drift temperature coefficient
- High overload capability
- · High insulation capability
- Reference pin with two modes, Ref IN and Ref OUT
- · Test winding.

### **Applications**

- Leakage current measurement in transformerless PV inverters
- First human contact protection of PV arrays
- Failure detection in power sources
- Symmetrical fault detection
- Current leakage detection in stacked DC sources
- Single phase nominal current measurement up to ±35 A per wire (DC or AC).

#### **Standards**

• EN 61800-1: 1997

• EN 61800-2: 2015

• EN 61800-3: 2004

• UL 62109-1: 2010

• IEC 61010-1: 2010

• UL 508.

# **Application Domain**

Industrial.



### **Absolute maximum ratings**

Parameter	Symbol	Unit	Value
Maximum supply voltage	$U_{\rm Cmax}$	V	7
Maximum primary conductor temperature	$T_{\mathrm{B\;max}}$	°C	110
Maximum withstand primary peak current	$\hat{I}_{P}$	Α	3300

Stresses above these ratings may cause permanent damage. Exposure to absolute maximum ratings for extended periods may degrade reliability.

#### **UL 508: Ratings and assumptions of certification**

File # E189713 Volume: 2 Section: 11

#### **Standards**

- CSA C22.2 NO. 14-10 INDUSTRIAL CONTROL EQUIPMENT Date 2011/08/01
- UL 508 STANDARD FOR INDUSTRIAL CONTROL EQUIPMENT Date 2013

#### **Ratings**

Parameter	Symbol	Unit	Value
Primary involved potential		V RMS	300
Maximum surrounding air temperature	$T_{A}$	°C	105
Primary current	$I_{P}$	A	35
Secondary supply voltage	$U_{C}$	V DC	5
Output voltage	$U_{\mathrm{out}}$	V	0 to 5

#### **Conditions of acceptability**

When installed in the end-use equipment, consideration shall be given to the following:

- 1 These devices must be mounted in a suitable end-use enclosure.
- 2 The terminals have not been evaluated for field wiring.
- 3 The LDSR xx-TP Series shall be used in a pollution degree 2 environment or better.
- 4 Low voltage circuits are intended to be powered by a circuit derived from an isolating source (such as a transformer, optical isolator, limiting impedance or electro-mechanical relay) and having no direct connection back to the primary circuit (other than through the grounding means).
- 5 These devices are intended to be mounted on the printed wiring board of the end-use equipment (with a minimum CTI of 100).
- 6 LDSR xx-TP Series: based on results of temperature tests, in the end-use application, a maximum of 110°C cannot be exceeded on the primary jumper.

#### Marking

Only those products bearing the UL or UR Mark should be considered to be Listed or Recognized and covered under UL's Follow-Up Service. Always look for the Mark on the product.



# **Insulation coordination**

Parameter	Symbol	Unit	Value	Comment		
RMS voltage for AC insulation test, 50 Hz, 1 min	$U_{d}$	kV	1.71	According to 62109-1		
Impulse withstand voltage 1.2/50 μs	$U_{\mathrm{Ni}}$	kV	4			
Partial discharge RMS test voltage (q <sub>m</sub> < 10 pC)	$U_{\mathrm{t}}$	V	990			
Clearance (pri sec.)	$d_{\mathrm{CI}}$	mm	See outline drawing in page 10			
Creepage distance (pri sec.)	$d_{Cp}$	] ''''''	See outline drawing in page 10			
Case material	-	-	V0	According to UL 94		
Comparative tracking index	CTI		600			
Application example		V	300	Basic insulation according to UL 62109, CAT III, PD2		

# **Environmental and mechanical characteristics**

Parameter	Symbol	Unit	Min	Тур	Max	Comment
Ambient operating temperature	$T_{A}$	°C	-40		105	
Ambient storage temperature	$T_{\mathrm{S}}$	°C	-50		105	
Mass	m	g		25		



### **Electrical data**

At  $T_A$  = 25 °C,  $U_C$  = +5 V, unless otherwise noted (lines with \* in the condition column apply over the ambient temperature range). See Min, Max, typ. definition paragraph in page 6.

Parameter	Symbol	Unit	Min	Тур	Max	*	Comment
Primary nominal residual RMS current	$I_{ m PRN}$	mA		300		*	
Primary residual current, measuring range	$I_{ m PRM}$	mA	-900		900	*	
Supply voltage	$U_{C}$	V	4.75	5	5.25	*	
Current consumption	$I_{\mathtt{C}}$	mA		18	20.5		$+I_{\rm p}$ (mA)/ $N_{\rm S}$ with $N_{\rm S}$ = 40 turns
Internal voltage reference	$U_{\mathrm{l}\mathrm{ref}}$	V	2.485	2.5	2.515		
Internal voltage source current reference	$I_{ m l\ ref}$	μΑ			400		
External voltage reference	$U_{\rm E \; ref}$	V	2.25		2.75		
Current to force a voltage external reference	-	mA			1.5		
Electrical offset current referred to primary	$I_{\mathrm{OE}}$	mA	-40		40		
Temperature coefficient of $I_{\rm OE}$ @ $I_{\rm P}$ = 0 A	TCI <sub>OE</sub>	mA/°C	-0.40	±0.17	0.40		
Magnetic offset after 1000 × $I_{PN}$	$I_{OM}$	mA		8			
Nominal sensitivity	$S_{N}$	V/A		2.22			
Sensitivity error	$arepsilon_S$	%	-2		2		For $R_L > 500 \text{ k}\Omega$
Temperature coefficient of S	TCS	ppm/K			±250		
Linearity error	$arepsilon_{L}$	% of $I_{\rm PRN}$	-3		3		
RMS noise current 1 Hz 2 kHz referred to primary	$I_{no}$	mA		7.5			
Delay time @ 10 % of I <sub>PN</sub>	t <sub>D 10</sub>	μs		25			For $R_L > 500 \text{ k}\Omega$ ; di/dt = 3 mA/ $\mu$ s
Delay time @ 90 % of I <sub>PN</sub>	t <sub>D 90</sub>	μs		300			For $R_L > 500 \text{ k}\Omega$ ; di/dt = 3 mA/ $\mu$ s
Start-up time	$t_{ m start}$	ms		220			
Frequency bandwidth (-3 dB)	BW	kHz		2			For $R_L > 500 \text{ k}\Omega$
Error	ε	mA	-40		40	*	Without initial offset
Error @ 30 mA	ε	mA	-8		8		For ±30 mA instantaneous DC jump
Error @ 60 mA	ε	mA	-12		12		For ±60 mA instantaneous DC jump
Error @ 150 mA	ε	mA	-20		20		For ±150 mA instantaneous DC jump
Degauss time		ms		120			
	IN Low	V			1.62		
Degauss pin input voltage	IN High	V	3.42				
	Pulse duration	ms	0.6				



# Performance parameters definition

# **Transducer simplified model**

The static model of the transducer at temperature  $T_{A}$  is:

$$U_{\mathrm{out}} = S \cdot I_{\mathrm{P}} + \varepsilon$$
 In which  $\varepsilon$  =

$$U_{\text{OE}} + U_{\text{OT}}(T_{\text{A}}) + \varepsilon_{\scriptscriptstyle{S}} \cdot I_{\text{P}} \cdot S + \varepsilon_{\text{L}}\left(I_{\text{PRM}}\right) \cdot I_{\text{PRM}} \cdot S + TCS \cdot (T_{\text{A}} - 25) \cdot I_{\text{P}} \cdot S$$

With:  $I_{PRMmax}$ : max primary residual measuring range

applied to the transducer

 $U_{\mathrm{out}}$  : output voltage (V)

 $\begin{array}{ll} T_{\rm A} & : {\rm ambient\ operating\ temperature\ (^{\circ}{\rm C})} \\ U_{{\rm O}\,{\rm E}} & : {\rm electrical\ offset\ voltage\ (V)} \\ U_{{\rm O}\,{\rm T}}(T_{\rm A}) & : {\rm temperature\ variation\ of\ } U_{\rm O}\,{\rm at} \end{array}$ 

temperature  $T_A$  (°C)

S : sensitivity of the transducer (V/At)
TCS : temperature coefficient of S

 $\varepsilon_{\rm c}$  : sensitivity error

 $\varepsilon_{\rm L}(I_{\rm P\,R\,M})$  : linearity error for  $I_{\rm P\,R\,M\,max}$ 

This model is valid for primary ampere-turns  $I_{\rm P}$  between  $-I_{\rm P\,R\,M}$  and + $I_{\rm P\,R\,M}$  only.

### **Pre-conditioning**

Before any test measure the transducer is pre conditioned by applying calibrated differential current cycles.

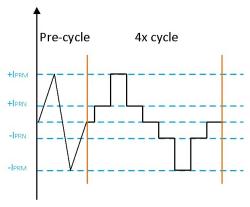


Figure 1: Pre-conditioning differential current cycles

#### Sensitivity and linearity

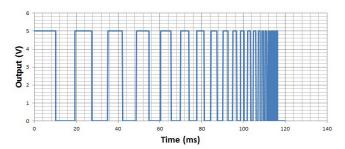
To measure sensitivity and linearity, the primary current (DC) is cycled from 0 to  $I_{\text{PRM}}$  then to  $\neg I_{\text{PRM}}$  and back to 0 (equally spaced  $I_{\text{PRM}}/10$  steps). The sensitivity S is defined as the slope of the linear regression line for a cycle between  $\pm I_{\text{PRN}}$ . The linearity error  $\varepsilon_{\text{L}}$  is the maximum positive or negative difference between the measured points and the linear regression line, expressed in % of  $I_{\text{PRM}}$ .

#### **Degauss**

A rising edge on the "Degauss" pin will initiate the degauss cycle. During the cycle the output  $U_{\rm out}$  does not carry relevant information.

Notes: 1) a degauss cycle is automatically initiated at power up the "Degauss" pin is provided with a 10 kΩ pull down resistor and can be left unconnected.

The figure below describes the expected output during a degauss cycle.



# **Magnetic offset**

The magnetic offset current  $I_{\rm O\,M}$  is the consequence of a current on the primary side ("memory effect" of the transducer's ferromagnetic parts). It is measured using the following primary current cycle.  $I_{\rm O\,M}$  depends on the current value  $I_{\rm P1}$  ( $I_{\rm P1}$  >  $I_{\rm P\,M}$ ).

$$I_{\text{OM}} = \frac{I_{\text{S}}(t_1) - I_{\text{S}}(t_2)}{2} \cdot \frac{1}{S}$$

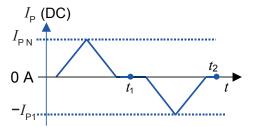


Figure 2: Current cycle used to measure magnetic and electrical offset (transducer supplied)



# Performance parameters definition

#### **Electrical offset**

The electrical offset current  $I_{\rm O\,E}$  can either be measured when the ferro-magnetic parts of the transducer are:

- · completely demagnetized, which is difficult to realize,
- or in a known magnetization state, like in the current cycle shown in figure number.

Using the current cycle shown in figure ..., the electrical offset

$$I_{\text{OE}} = \frac{I_{\text{out}}(t_1) + I_{\text{out}}(t_2)}{2}$$

The temperature variation  $I_{\rm O\ T}$  of the electrical offset current  $I_{\rm O\ E}$  is the variation of the electrical offset from 25 °C to the considered temperature:

$$I_{OT}(T) = I_{OE}(T) - I_{OE}(25^{\circ} \text{ C})$$

Note: the transducer has to be demagnetized prior to the application of the current cycle (for example with a demagnetization tunnel).

#### **Total error**

The total error  $\varepsilon_{\mathrm{tot}}$  is the error at  $\pm$   $I_{\mathrm{P\,N}}$ , relative to the rated value  $I_{\rm P\,N}.$  It includes all errors mentions above:

- the electrical offset I<sub>OE</sub>
- the magnetic offset I<sub>OM</sub>
- the sensitivity error  $\varepsilon_{\varsigma}$
- the linearity error  $\varepsilon_{l}$  (to  $I_{PN}$ )

# **Delay times**

The delay time  $t_{\rm D\,10}$  @ 10 % and the delay time  $t_{\rm D\,90}$  @ 90 % are shown in figure 3.

Both depend on the primary current di/dt. They are measured at nominal current.

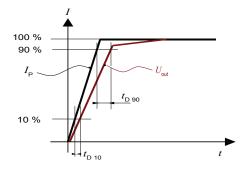


Figure 3:  $t_{\rm D\,10}$  (delay time @ 10 %) and  $t_{\rm D\,90}$  (delay time @ 90 %)



# **Application information**

# Decoupling supply voltage $U_c$ (5 V):

RCM transducers are already provided with internal decoupling capacitors.

Depending on the design it is advisable to add an external decoupling: 1 µF or more.

If fast differential current surges are to be expected the decoupling capacitor should be increased in order to absorb the energy from internal protection diodes.

In this case the capacitor should be increased to more than 10 µF.

Protection of test winding:

If fast differential current surges are to be expected, the circuit connected to the test winding shall be protected to absorb the energy coupled from the primary surge.

# Load on $U_{\mathrm{out}}$ :

The maximum  $U_{out}$  is 10 mA. The load on this output should be adapted to not exceed this current.

# Decoupling reference $U_{\text{ref}}$ :

The maximum decoupling capacitor value is 47 nF.

# Output $U_{\text{out}}$ properties:

The output is a direct Opamp output. The output current is limited to 10 mA.

#### Using an external reference voltage:

If the  $U_{\text{ref}}$  pin of the transducer is not used it could be either left unconnected or filtered according to the previous paragraph "Reference  $U_{\text{ref}}$ ".

If an external voltage reference is used its source capability must be at least 1.5 mA.

### Definition of typical, minimum and maximum values

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as well as values shown in "typical" graphs.

On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval. Unless otherwise stated (e.g. "100 % tested"), the LEM definition for such intervals designated with "min" and "max" is that the probability for values of samples to lie in this interval is 99.73 %. For a normal (Gaussian) distribution, this corresponds to an interval between -3 sigma and +3 sigma.

If "typical" values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between -sigma and +sigma for a normal distribution.

Typical, maximal and minimal values are determined during the initial characterization of the product.



### Primary nominal residual current and primary nominal current

The primary nominal residual current is the sum of the instantaneous values of all currents flowing through the primary circuit of the transducer.

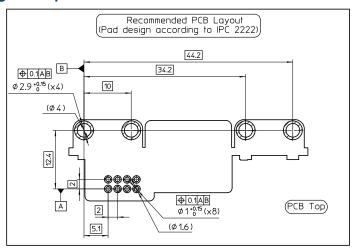
The presence of a primary nominal current DC or AC may lead to an additional uncertainty.

For example, with a primary nominal current of 35 A the uncertainty is typically 1.2 % of the primary nominal residual current (1.2 % of 300 mA giving 3.6 mA).

#### **Test LDSR transducer**

Twenty turns are available on the magnetic core in order to perform tests. The current is limited to 50 mA.

#### PCB footprint according to the product



Note: the dimension of customer PCB tracks (width & thickness) and the LEM transducer's primary PCB are linked and can influence on each other temperature heating.

#### **Assembly on PCB**

Recommended PCB hole diameter

Maximum PCB thickness

 Wave soldering profile No clean process only 2.9 mm for primary pin1 mm for secondary pin

2.4 mm

maximum 260 °C, 10 s

# Safety

This transducer must be used in limited-energy secondary circuits according to IEC 61010-1.



This transducer must be used in electric/electronic equipment with respect to applicable standards and safety requirements in accordance with the manufacturer's operating instructions.

Caution, risk of electrical shock



When operating the transducer, certain parts of the module can carry hazardous voltage (e.g. primary busbar, power supply). Ignoring this warning can lead to injury and/or cause serious damage.

This transducer is a build-in device, whose conducting parts must be inaccessible after installation.

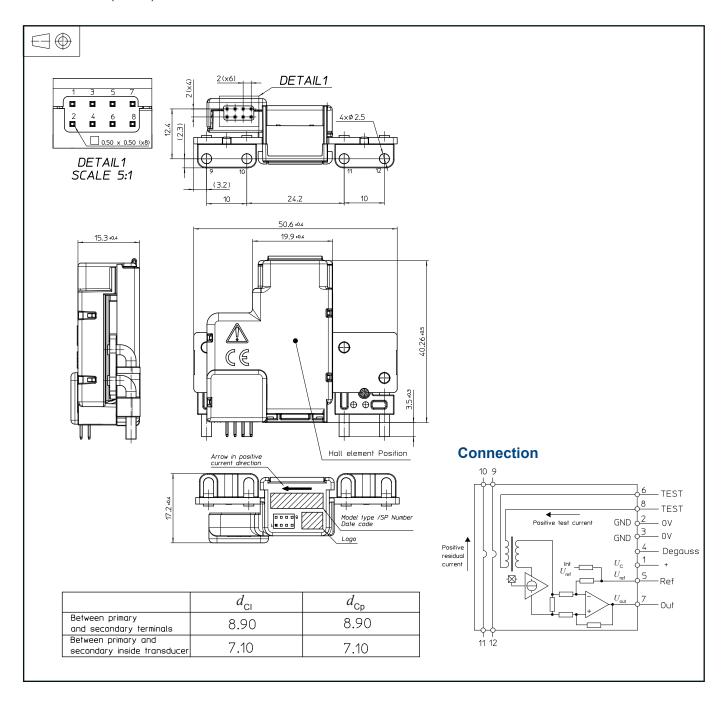
A protective housing or additional shield could be used. Main supply must be able to be disconnected.

#### Remark

Installation of the transducer must be done unless otherwise specified on the datasheet, according to LEM Transducer Generic Mounting Rules. Please refer to LEM document N°ANE120504 available on our Web site: https://www.lem.com/en/file/3137/download/.

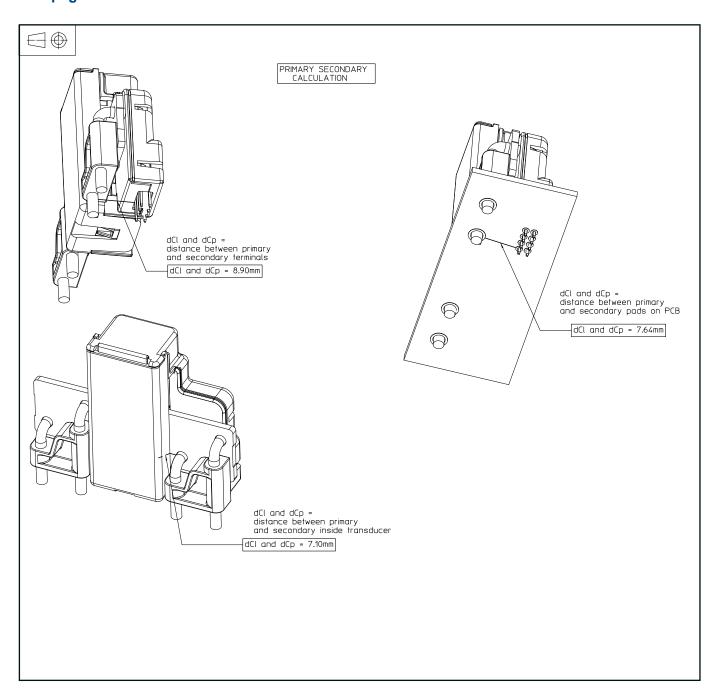


# **Dimensions** (in mm)





# **Creepage and Clearance**







# **Packaging information**

Standard delivery in cardboard: L  $\times$  W  $\times$  H: 300  $\times$  200  $\times$  200 mm Each carboard contains 60 parts, placed into 3 Polystyrene-made trays of 20 parts each one. Both trays and carboard are ESD-compliant. The typical weight of the cardboard is 2.5 Kg.

